

Notice of References Cited

Application/Control No.

09/002,906

Applicant(s)/Patent Under
Reexamination
WUGOFSKI ET AL.

Examiner

Hai Tran

Art Unit

2611

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6002394	12-1999	Schein et al.	725/39
	B	US-			
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	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N	EP 0 572 090 A2	12-1993	EPO	Strubbe	H04N 7/08
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NON-PATENT DOCUMENTS

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